



74ALVT162245

16-bit transceiver with 30 Ohm termination resistors; 3-state

Rev. 6 — 25 June 2024

Product data sheet

1. General description

The 74ALVT162245 is a 16-bit transceiver with 30 Ω termination resistors and 3-state outputs. The device can be used as two 8-bit transceivers or one 16-bit transceiver. The device features two output enables (1OE and 2OE) each controlling eight outputs, and two send/receive (1DIR and 2DIR) inputs for direction control. A HIGH on nOE causes the outputs to assume a high-impedance OFF-state.

2. Features and benefits

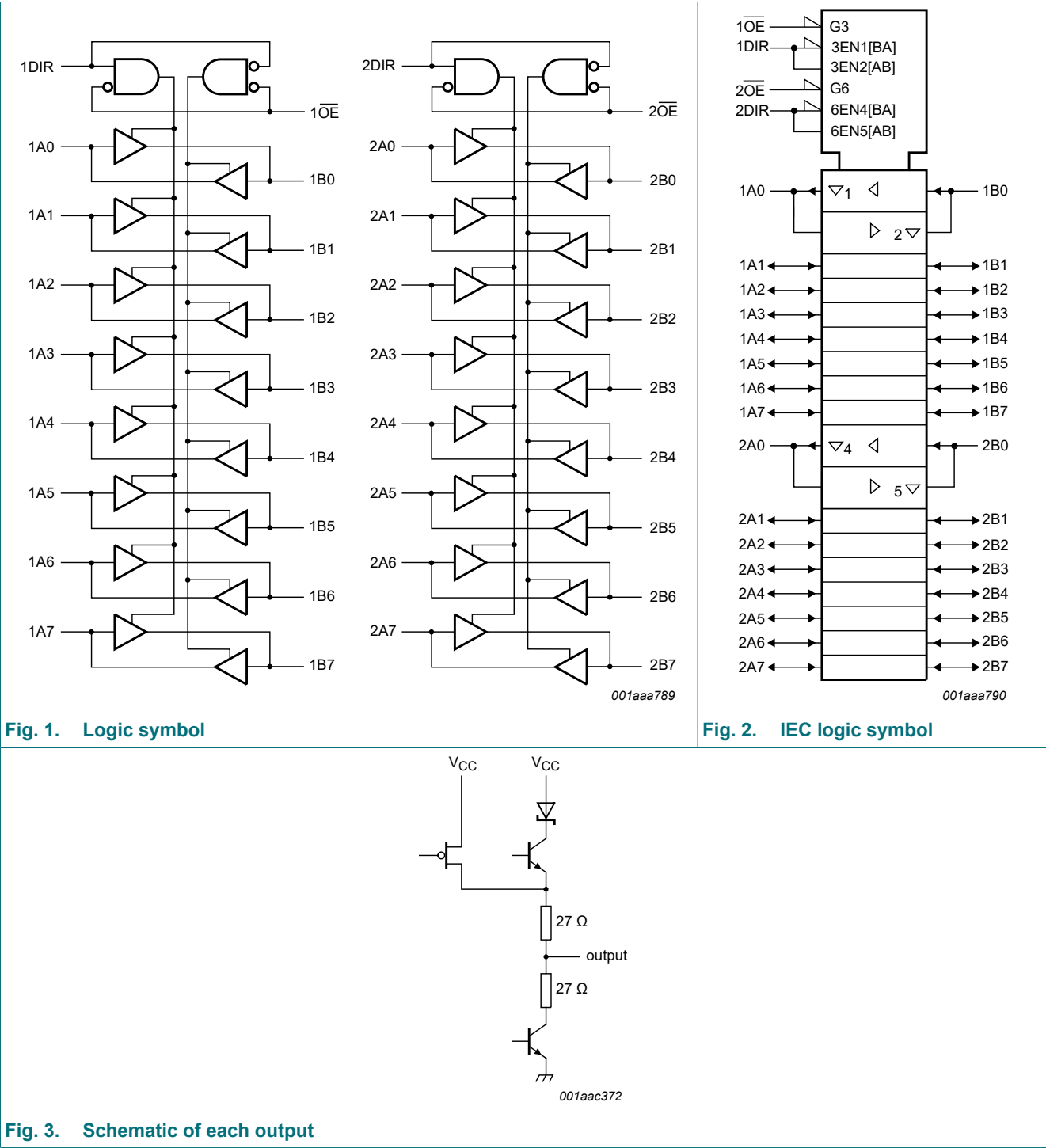
- 16-bit bidirectional bus interface
- 3-State buffers
- Wide supply voltage range from 2.3 to 3.6 V
- 5V I/O compatible
- Overvoltage tolerant inputs to 5.5 V
- Output capability: +12 mA/–12 mA
- Direct interface with TTL levels
- Input and output interface capability to systems at 5 V supply
- BiCMOS high speed and output drive
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Outputs include series resistance of 30 Ω making external termination resistors unnecessary
- I_{OFF} circuitry provides partial Power-down mode operation
- Power-up 3-State
- No bus current loading when output is tied to 5 V bus
- Latch-up performance exceeds 500 mA per JESD 78 Class II Level B
- ESD protection:
 - HBM: ANSI/ESDA/JEDEC JS-001 class 2 exceeds 2000 V
 - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to +85 °C

3. Ordering information

Table 1. Ordering information

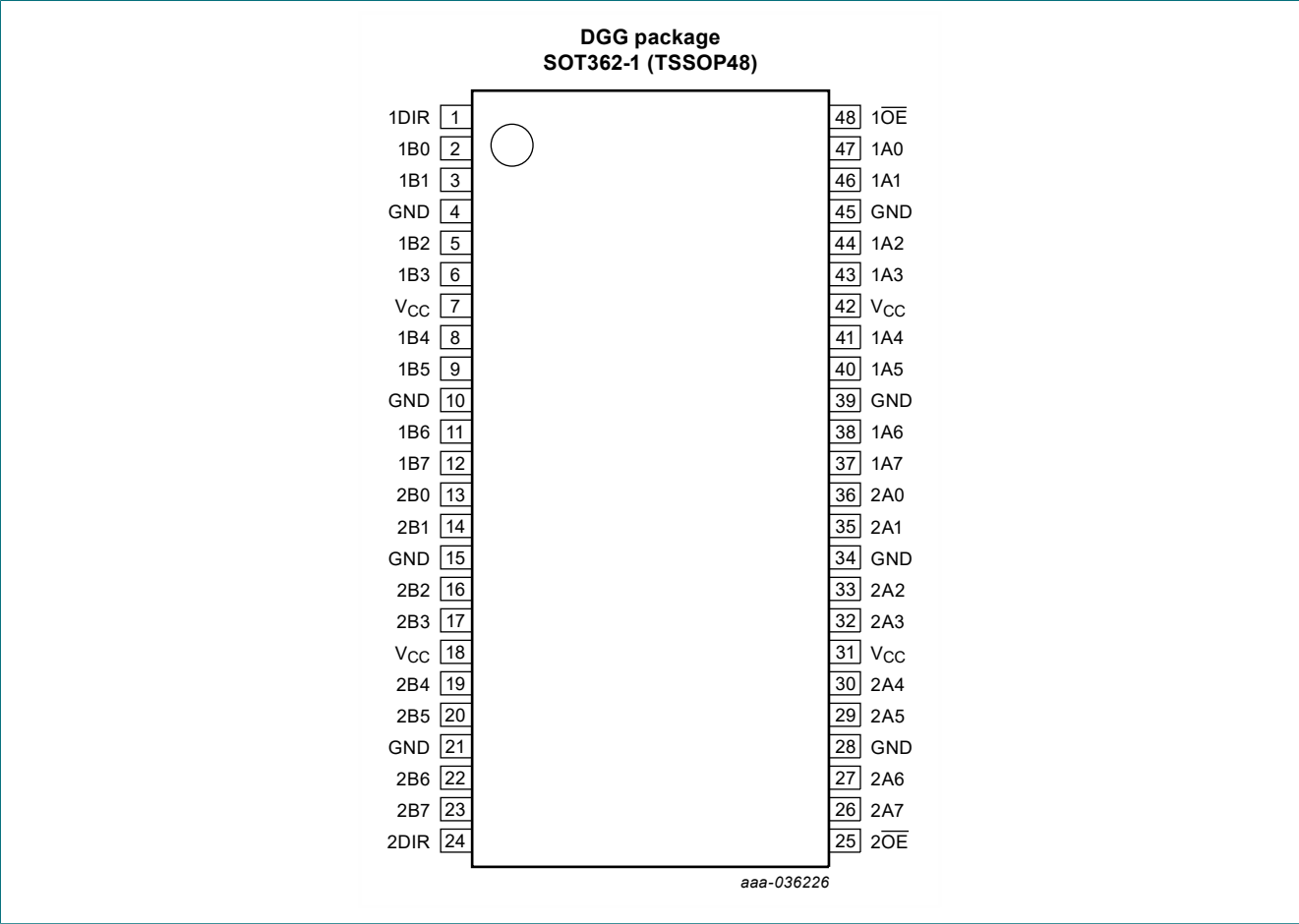
Type number	Package			
	Temperature range	Name	Description	Version
74ALVT162245DGG	-40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1

4. Functional diagram



5. Pinning information

5.1. Pinning



5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
1DIR, 2DIR	1, 24	direction control input
1A0, 1A1, 1A2, 1A3, 1A4, 1A5, 1A6, 1A7	47, 46, 44, 43, 41, 40, 38, 37	data input/output
2A0, 2A1, 2A2, 2A3, 2A4, 2A5, 2A6, 2A7	36, 35, 33, 32, 30, 29, 27, 26	data input/output
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
1B0, 1B1, 1B2, 1B3, 1B4, 1B5, 1B6, 1B7	2, 3, 5, 6, 8, 9, 11, 12	data input/output
2B0, 2B1, 2B2, 2B3, 2B4, 2B5, 2B6, 2B7	13, 14, 16, 17, 19, 20, 22, 23	data input/output
1OE, 2OE	48, 25	output enable input (active-LOW)
VCC	7, 18, 31, 42	supply voltage

6. Functional description

Table 3. Function table

H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

Control		Input/output	
nOE	nDIR	nAn	nBn
L	L	output nAn = nBn	input
L	H	input	output nBn = nAn
H	X	Z	Z

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		−0.5	+4.6	V
V _I	input voltage	[1]	−0.5	+7.0	V
V _O	output voltage	output in OFF-state or HIGH-state [1]	−0.5	+7.0	V
I _{IK}	input clamping current	V _I < 0 V	−50	-	mA
I _{OK}	output clamping current	V _O < 0 V	−50	-	mA
I _O	output current	output in LOW-state	-	128	mA
		output in HIGH-state	−64	-	mA
T _{stg}	storage temperature		−65	+150	°C
T _j	junction temperature	[2]	-	+150	°C

- [1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- [2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 3.3 V ± 0.3 V		Unit
			Min	Max	Min	Max	
V _{CC}	supply voltage		2.3	2.7	3.0	3.6	V
V _I	input voltage		0	5.5	0	5.5	V
I _{OH}	HIGH-level output current		-	−8	-	−12	mA
I _{OL}	LOW-level output current		-	12	-	12	mA
Δt/ΔV	input transition rise and fall rate	outputs enabled	-	10	-	10	ns/V
T _{amb}	ambient temperature	free-air	−40	+85	−40	+85	°C

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$						
V_{IK}	input clamping voltage	$V_{CC} = 2.3\text{ V}$; $I_{IK} = -18\text{ mA}$	-	-0.85	-1.2	V
V_{IH}	HIGH-level input voltage	$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	1.7	-	-	V
V_{IL}	LOW-level input voltage	$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	-	-	0.7	V
V_{OH}	HIGH-level output voltage	$V_{CC} = 2.3\text{ V}$; $I_O = -8\text{ mA}$	1.7	-	-	V
V_{OL}	LOW-level output voltage	$V_{CC} = 2.3\text{ V}$; $I_O = 12\text{ mA}$	-	0.6	0.7	V
I_I	input leakage current	all input pins [2]				
		$V_{CC} = 0\text{ V}$ or 2.7 V ; $V_I = 5.5\text{ V}$	-	0.1	10	μA
		control pins				
		$V_{CC} = 2.7\text{ V}$; $V_I = V_{CC}$ or GND	-	0.1	± 1	μA
		I/O data pins [2]				
		$V_{CC} = 2.7\text{ V}$; $V_I = V_{CC}$	-	0.1	1	μA
		$V_{CC} = 2.7\text{ V}$; $V_I = 0\text{ V}$	-	0.1	-5	μA
I_{OFF}	power-off leakage current	$V_{CC} = 0\text{ V}$; V_I or $V_O = 0\text{ V}$ to 4.5 V	-	0.1	± 100	μA
I_{BHL}	bus hold LOW current	data inputs; $V_{CC} = 2.3\text{ V}$; $V_I = 0.7\text{ V}$ [3]	-	90	-	μA
I_{BHH}	bus hold HIGH current	data inputs; $V_{CC} = 2.3\text{ V}$; $V_I = 1.7\text{ V}$ [3]	-	-75	-	μA
I_{EX}	external current	output in HIGH-state when $V_O > V_{CC}$; $V_O = 5.5\text{ V}$; $V_{CC} = 2.3\text{ V}$	-	20	125	μA
$I_{O(pu/pd)}$	power-up/power-down output current	$V_{CC} \leq 1.2\text{ V}$; $V_O = 0.5\text{ V}$ to V_{CC} ; $V_I = \text{GND}$ or V_{CC} ; $n\overline{OE} = \text{don't care}$ [4]	-	40	100	μA
I_{CC}	supply current	$V_{CC} = 2.7\text{ V}$; $V_I = \text{GND}$ or V_{CC} ; $I_O = 0\text{ A}$				
		outputs HIGH	-	0.04	0.1	mA
		outputs LOW	-	2.5	4.5	mA
		outputs disabled [5]	-	0.04	0.1	mA
ΔI_{CC}	additional supply current	per input pin; $V_{CC} = 2.3\text{ V}$ to 2.7 V ; one input at $V_{CC} - 0.6\text{ V}$; other inputs at V_{CC} or GND [6]	-	0.05	0.4	mA
C_I	input capacitance	nDIR and $n\overline{OE}$; $V_I = 0\text{ V}$ or V_{CC}	-	3	-	pF
$C_{I/O}$	input/output capacitance	$V_{I/O} = 0\text{ V}$ or V_{CC}	-	9	-	pF

16-bit transceiver with 30 Ohm termination resistors; 3-state

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
V_{CC} = 3.3 V ± 0.3 V						
V _{IK}	input clamping voltage	V _{CC} = 3.0 V; I _{IK} = -18 mA	-	-0.85	-1.2	V
V _{IH}	HIGH-level input voltage	V _{CC} = 3.3 V ± 0.3 V	2.0	-	-	V
V _{IL}	LOW-level input voltage	V _{CC} = 3.3 V ± 0.3 V	-	-	0.8	V
V _{OH}	HIGH-level output voltage	V _{CC} = 3.0 V; I _O = -12 mA	2.0	2.3	-	V
V _{OL}	LOW-level output voltage	V _{CC} = 3.0 V; I _O = 12 mA	-	0.6	0.8	V
I _I	input leakage current	all input pins [2]				
		V _{CC} = 0 V or 3.6 V; V _I = 5.5 V	-	0.1	10	μA
		control pins				
		V _{CC} = 3.6 V; V _I = V _{CC} or GND	-	0.1	±1	μA
		I/O data pins [2]				
		V _{CC} = 3.6 V; V _I = V _{CC}	-	0.5	1	μA
		V _{CC} = 3.6 V; V _I = 0 V	-	0.1	-5	μA
I _{OFF}	power-off leakage current	V _{CC} = 0 V; V _I or V _O = 0 V to 4.5 V	-	0.1	±100	μA
I _{BHL}	bus hold LOW current	data inputs; V _{CC} = 3 V; V _I = 0.8 V	75	130	-	μA
I _{BHH}	bus hold HIGH current	data inputs; V _{CC} = 3 V; V _I = 2.0 V	-75	-140	-	μA
I _{BHLO}	bus hold LOW overdrive current	data inputs; V _{CC} = 3.6 V; V _I = 0 V to 3.6 V [7]	500	-	-	μA
I _{BHHO}	bus hold HIGH overdrive current	data inputs; V _{CC} = 3.6 V; V _I = 0 V to 3.6 V [7]	-500	-	-	μA
I _{EX}	external current	output in HIGH-state when V _O > V _{CC} ; V _O = 5.5 V; V _{CC} = 3.0 V	-	50	125	μA
I _{O(pu/pd)}	power-up/power-down output current	V _{CC} ≤ 1.2 V; V _O = 0.5 V to V _{CC} ; V _I = GND or V _{CC} ; n $\overline{\text{OE}}$ = don't care [8]	-	40	±100	μA
I _{CC}	supply current	V _{CC} = 3.6 V; V _I = GND or V _{CC} ; I _O = 0 A				
		outputs HIGH	-	0.07	0.1	mA
		outputs LOW	-	3.5	5	mA
		outputs disabled [5]	-	0.07	0.1	mA
ΔI _{CC}	additional supply current	per input pin; V _{CC} = 3 V to 3.6 V; one input at V _{CC} - 0.6 V; other inputs at V _{CC} or GND [6]	-	0.04	0.4	mA
C _I	input capacitance	nDIR and n $\overline{\text{OE}}$; V _I = 0 V or V _{CC}	-	3	-	pF
C _{I/O}	input/output capacitance	V _{I/O} = 0 V or V _{CC}	-	9	-	pF

[1] Typical values for V_{CC} = 2.3 V to 2.7 V are measured at V_{CC} = 2.5 V and T_{amb} = 25 °C.

Typical values for V_{CC} = 3.0 V to 3.6 V are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.

[2] Unused pins at V_{CC} or GND.

[3] Not guaranteed.

[4] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms.

From V_{CC} = 1.2 V to V_{CC} = 2.5 V ± 0.2 V a transition time of 100 μs is permitted. This parameter is valid for T_{amb} = 25 °C only.

[5] I_{CC} with outputs disabled is measured with outputs pulled to V_{CC} or GND.

[6] This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.

[7] This is the bus hold overdrive current required to force the input to the opposite logic state.

[8] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms.

From V_{CC} = 1.2 V to V_{CC} = 3.0 V ± 0.3 V a transition time of 100 μs is permitted. This parameter is valid for T_{amb} = 25 °C only.

10. Dynamic characteristics

Table 7. Dynamic characteristics
Voltages are referenced to GND (ground = 0 V); $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$; for test circuit see Fig. 6.

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
V _{CC} = 2.5 V ± 0.2 V						
t _{PLH}	LOW to HIGH propagation delay	nAn to nBn or nBn to nAn; see Fig. 4	1.5	2.9	5.3	ns
t _{PHL}	HIGH to LOW propagation delay	nAn to nBn or nBn to nAn; see Fig. 4	1.5	2.4	4.7	ns
t _{PZH}	OFF-state to HIGH propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.5	4.3	6.3	ns
t _{PZL}	OFF-state to LOW propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.5	3.1	4.6	ns
t _{PHZ}	HIGH to OFF-state propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.5	4.2	6.2	ns
t _{PLZ}	LOW to OFF-state propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.5	3.3	5.1	ns
V _{CC} = 3.3 V ± 0.3 V						
t _{PLH}	LOW to HIGH propagation delay	nAn to nBn or nBn to nAn; see Fig. 4	0.5	2.3	3.6	ns
t _{PHL}	HIGH to LOW propagation delay	nAn to nBn or nBn to nAn; see Fig. 4	0.5	2.0	3.1	ns
t _{PZH}	OFF-state to HIGH propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.0	3.0	5.0	ns
t _{PZL}	OFF-state to LOW propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.0	2.6	3.9	ns
t _{PHZ}	HIGH to OFF-state propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.0	3.6	5.2	ns
t _{PLZ}	LOW to OFF-state propagation delay	n $\overline{\text{OE}}$ to nAn or n $\overline{\text{OE}}$ to nBn; see Fig. 5	1.0	3.0	4.6	ns

[1] Typical values for V_{CC} = 2.3 V to 2.7 V are measured at V_{CC} = 2.5 V and T_{amb} = 25 °C.
Typical values for V_{CC} = 3.0 V to 3.6 V are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.

10.1. Waveforms and test circuit

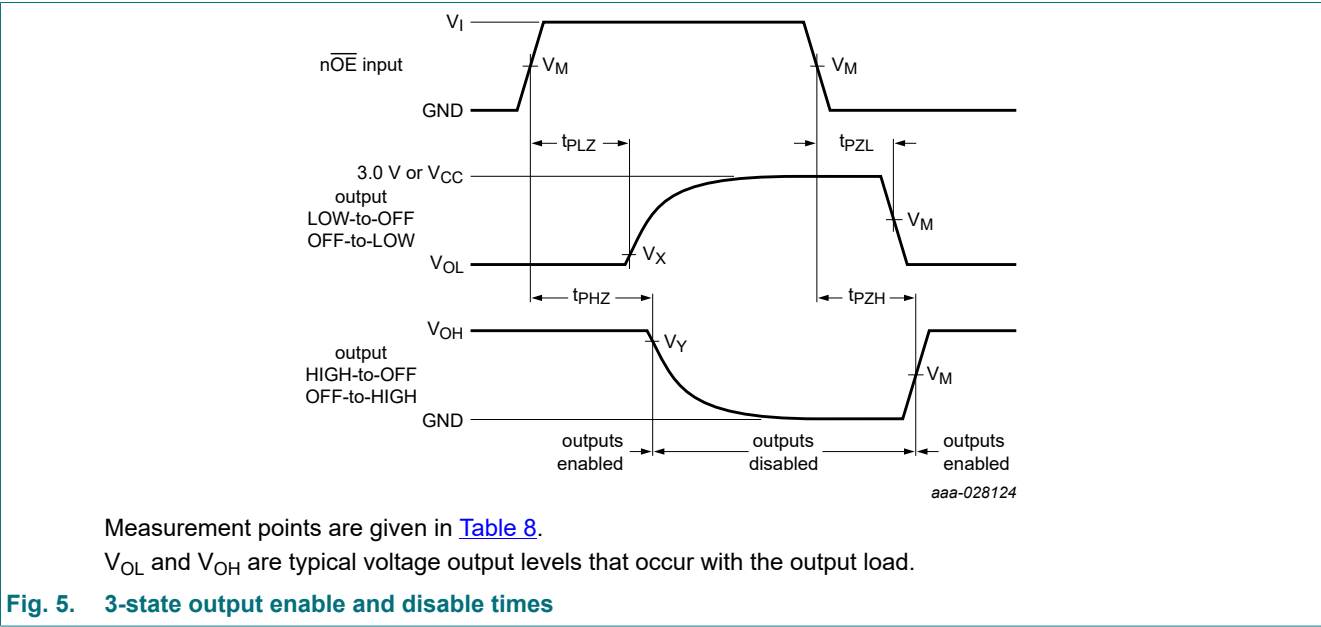
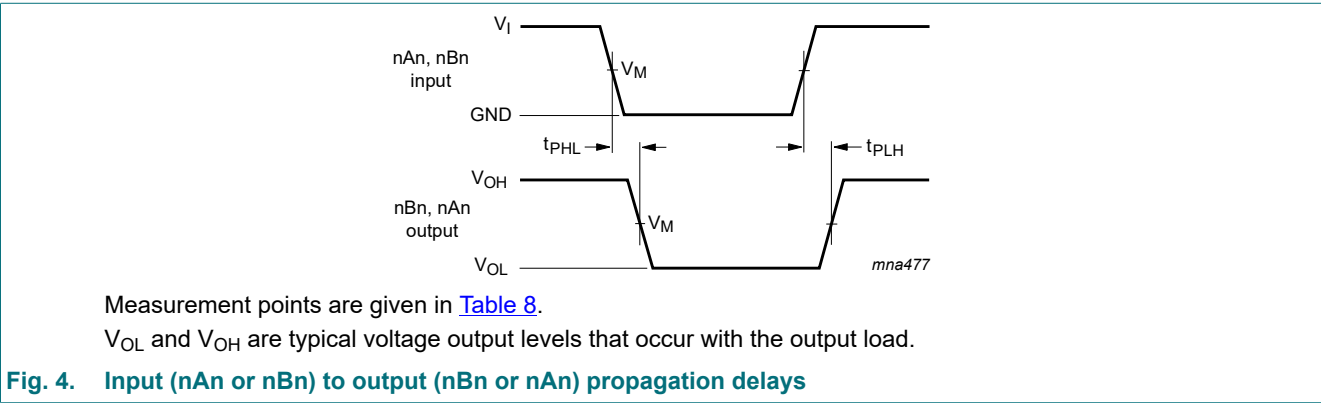


Table 8. Measurement points

V_{CC}	Input		Output		
	V_I	V_M	V_M	V_X	V_Y
$V_{CC} \leq 2.7\text{ V}$	V_{CC}	$0.5V_{CC}$	$0.5V_{CC}$	$V_{OL} + 0.1\text{ V}$	$V_{OH} - 0.1\text{ V}$
$V_{CC} \geq 3.0\text{ V}$	3.0 V	1.5 V	1.5 V	$V_{OL} + 0.3\text{ V}$	$V_{OH} - 0.3\text{ V}$

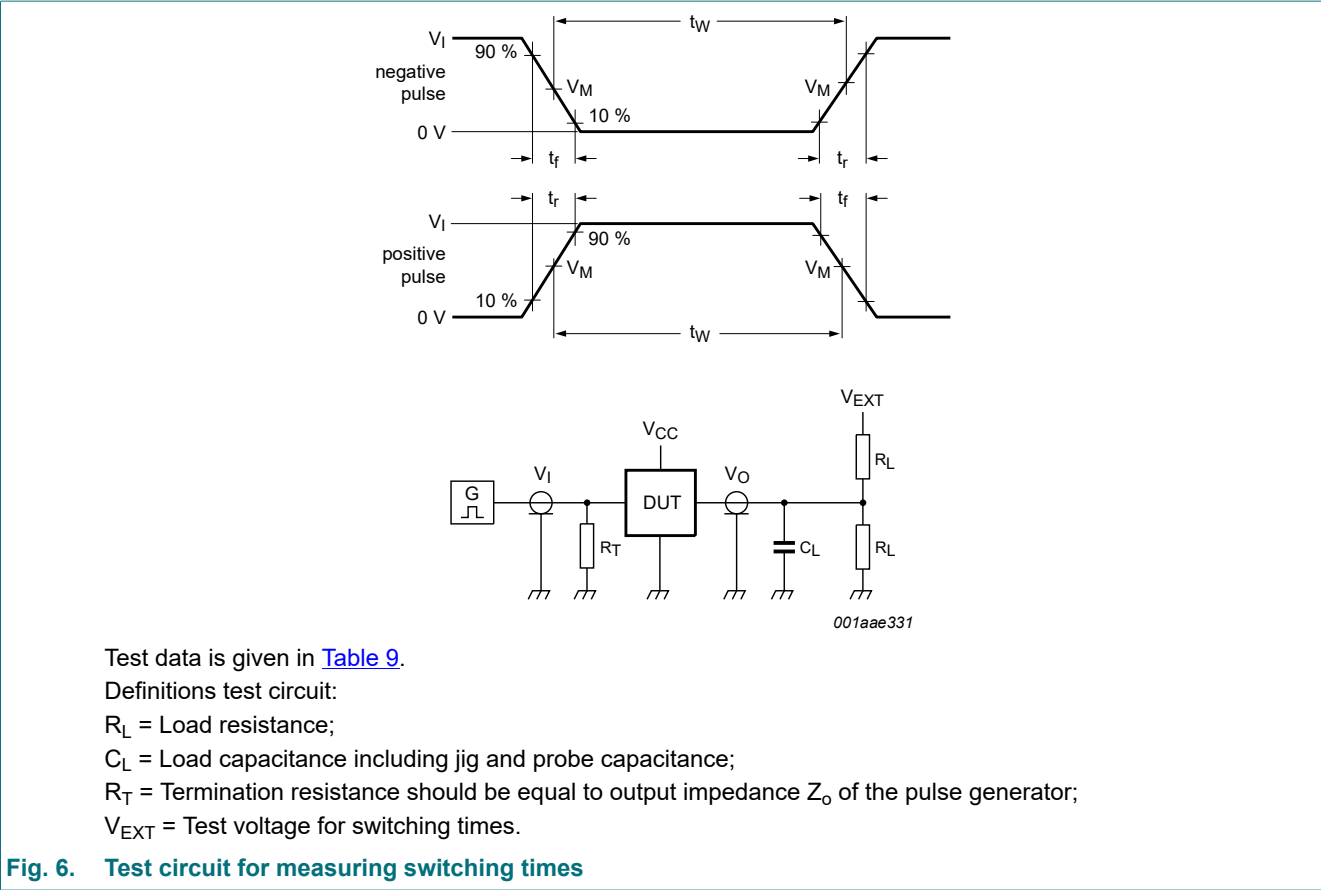


Table 9. Test data

Input				Load		V_{EXT}		
V_I	f_i	t_W	t_r, t_f	C_L	R_L	t_{PHZ}, t_{PZH}	t_{PLZ}, t_{PZL}	t_{PLH}, t_{PHL}
3.0 V or V_{CC} whichever is less	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	GND	6 V or $2V_{CC}$	open

11. Package outline

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1

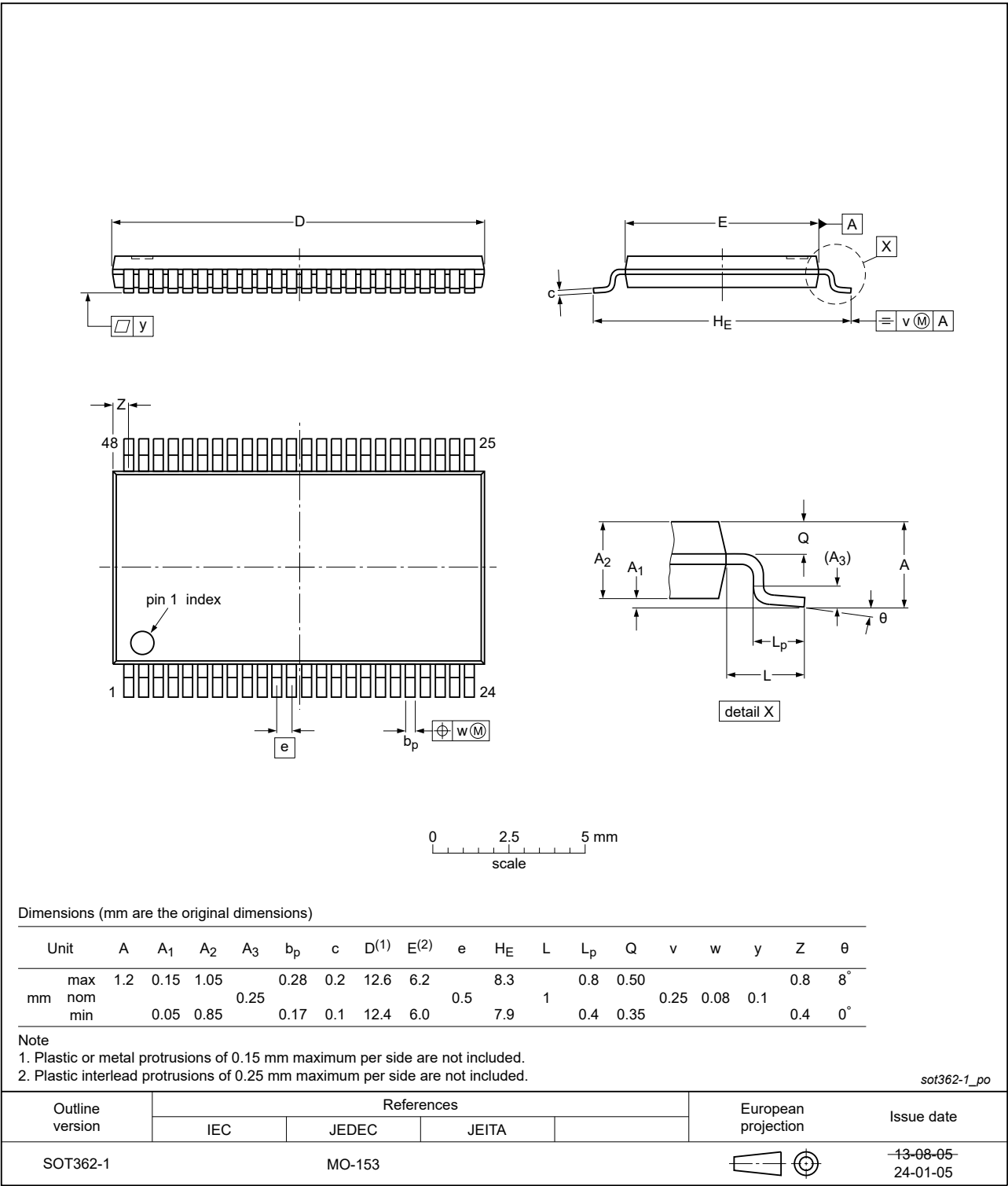


Fig. 7. Package outline SOT362-1 (TSSOP48)

12. Abbreviations

Table 10. Abbreviations

Acronym	Description
ANSI	American National Standards Institute
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
ESDA	ElectroStatic Discharge Association
HBM	Human Body Model
JEDEC	Joint Electron Device Engineering Council
TTL	Transistor-Transistor Logic

13. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ALVT162245 v.6	20240625	Product data sheet	-	74ALVT162245 v.5
Modifications:	Section 2: ESD specification updated according to the latest JEDEC standard.			
74ALVT162245 v.5	20240424	Product data sheet	-	74ALVT162245 v.4
Modifications:	Fig. 7: Updated package outline drawing SOT362-1 (TSSOP48).			
74ALVT162245 v.4	20210203	Product data sheet	-	74ALVT162245 v.3
Modifications:	- Type number 74ALVT162245DL (SOT370-1 / SSOP48) removed. Section 1 and Section 2 updated.			
74ALVT162245 v.3	20180129	Product data sheet	-	74ALVT162245 v.2
Modifications:	- The format of this data sheet has been redesigned to comply with the identity guidelines of Nexperia. - Legal texts have been adapted to the new company name where appropriate.			
74ALVT162245 v.2	19980213	Product specification	-	74ALVT162245 v.1
74ALVT162245 v.1	19960305	Product specification	-	-

14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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